

General Description

The WST2309 is the highest performance trench P-ch MOSFET with extreme high cell density , which provide excellent R_{DSON} and gate charge for most of the small power switching and load switch applications.

The WST2309 meet the RoHS and Green Prod uct requirement with full function reliability appro ved.

Features

- Advanced high cell density Trench technology
- Super Low Gate Charge
- Excellent CdV/dt effect decline
- 100% EAS Guaranteed
- Green Device Available

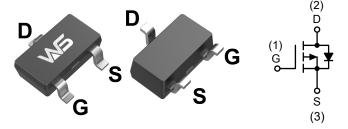
Product Summery

BV _{DSS}	R _{DSON} I _D	
-60V	165mΩ	-2.8A

Applications

- High Frequency Point-of-Load Synchronous
 Small power switching for MB/NB/UMPC/VGA
- Networking DC-DC Power System
- Load Switch

SOT-23-3L Pin Configuration



Absolute Maximum Ratings

Symbol	Parameter	Rating	Units
V_{DS}	Drain-Source Voltage	-60	V
V_{GS}	Gate-Source Voltage	±20	V
I _D @T _A =25℃	Continuous Drain Current, -V _{GS} @ -10V ¹	-2.8	А
I _D @T _A =70℃	Continuous Drain Current, -V _{GS} @ -10V ¹	-1.8	А
I _{DM}	Pulsed Drain Current ²	-8.4	А
P _D @T _C =25°C	Total Power Dissipation ³	1.5	W
T _{STG}	Storage Temperature Range	-55 to 150	$^{\circ}$
TJ	Operating Junction Temperature Range	-55 to 150	$^{\circ}$

Thermal Data

Symbol	Parameter	Тур.	Max.	Unit
$R_{ heta JA}$	Thermal Resistance Junction-Ambient ¹		125	°C/W
$R_{ heta JC}$	Thermal Resistance Junction-Case ¹		80	°C/W



Electrical Characteristics (T_J=25 °C, unless otherwise noted)

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit	
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V , I _D =-250uA	-60			V	
$\triangle BV_{DSS}/\triangle T_{J}$	BV _{DSS} Temperature Coefficient	Reference to 25°C , I _D =-1mA		-0.021		V/°C	
В	Static Drain-Source On-Resistance ²	V _{GS} =-10V , I _D =-1.5A		165	200	mO	
R _{DS(ON)}	Static Diain-Source On-Nesistance	V _{GS} =-4.5V , I _D =-1A		200	260	mΩ	
$V_{GS(th)}$	Gate Threshold Voltage	V _{GS} =V _{DS} . In =-250uA	-1.1	-1.7	-2.5	٧	
$\triangle V_{GS(th)}$	V _{GS(th)} Temperature Coefficient	V _{GS} =V _{DS} , I _D =-250uA		4.08		mV/℃	
	Drain Source Leakage Current	V_{DS} =-48V , V_{GS} =0V , T_J =25 $^{\circ}$ C			1		
I _{DSS}	Drain-Source Leakage Current	V_{DS} =-48V , V_{GS} =0V , T_J =55 $^{\circ}$ C			5	uA	
I _{GSS}	Gate-Source Leakage Current	V_{GS} = $\pm 20V$, V_{DS} = $0V$			±100	nA	
gfs	Forward Transconductance	V _{DS} =-10V , I _D =-1.5A		5.5		S	
Qg	Total Gate Charge (-4.5V)			4.6			
Q_{gs}	Gate-Source Charge	V _{DS} =-20V , V _{GS} =-4.5V , I _D =-1.5A		1.4		nC	
Q_{gd}	Gate-Drain Charge			1.6			
$T_{d(on)}$	Turn-On Delay Time			17.4			
T _r	Rise Time	V_{DD} =-15V , V_{GS} =-10V , R_G =3.3 Ω ,		5.4		no	
$T_{d(off)}$	Turn-Off Delay Time	I _D =-1A		37.2		ns	
T _f	Fall Time			2.4			
C _{iss}	Input Capacitance			456			
Coss	Output Capacitance	V _{DS} =-15V , V _{GS} =0V , f=1MHz		59		pF	
C _{rss}	Reverse Transfer Capacitance			38			

Diode Characteristics

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
Is	Continuous Source Current ^{1,4}	V _G =V _D =0V , Force Current			-2.8	Α
I _{SM}	Pulsed Source Current ^{2,4}	VG-VD-OV, POICE Current			-7.1	Α
V _{SD}	Diode Forward Voltage ²	V_{GS} =0V , I_{S} =-1A , T_{J} =25 $^{\circ}$ C			-1.2	V

^{1.} The data tested by surface mounted on a 1 inch² FR-4 board with 2OZ copper,t<10sec.

^{2.}The data tested by pulsed , pulse width ≤ 300 us , duty cycle $\leq 2\%$ 3.The power dissipation is limited by 150 $^{\circ}$ C junction temperature

^{4.} The data is theoretically the same as I_D and I_{DM} , in real applications, should be limited by total power dissipation.



Typical Characteristics

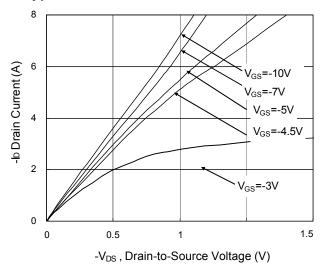


Fig.1 Typical Output Characteristics

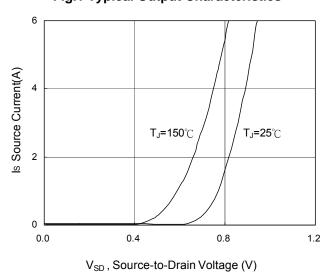


Fig.3 Forward Characteristics Of Reverse

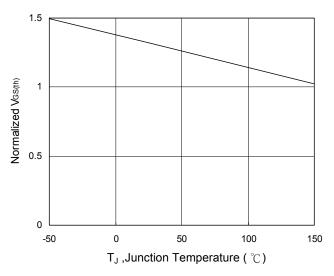


Fig.5 Normalized V_{GS(th)} v.s T_J

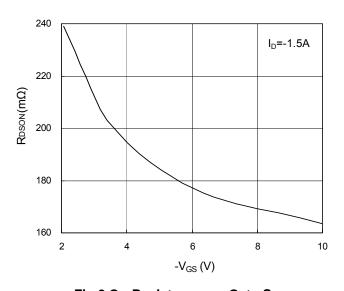


Fig.2 On-Resistance v.s Gate-Source

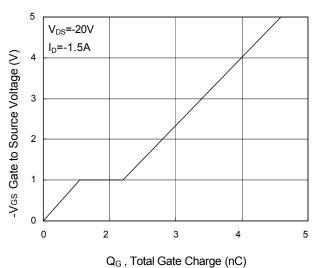


Fig.4 Gate-Charge Characteristics

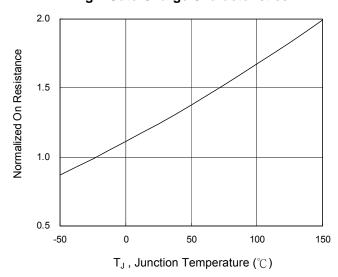
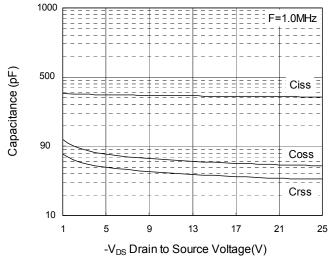


Fig.6 Normalized R_{DSON} v.s T_J





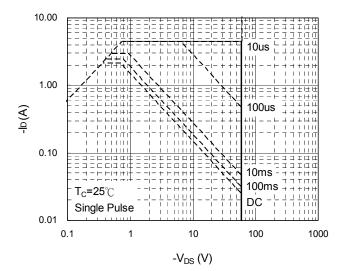


Fig.7 Capacitance

Fig.8 Safe Operating Area

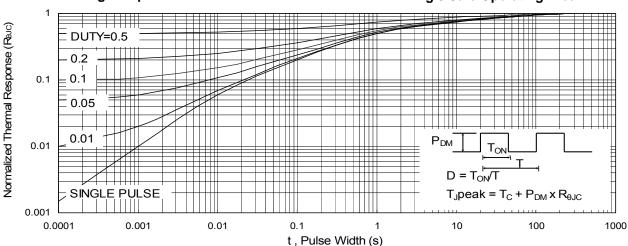
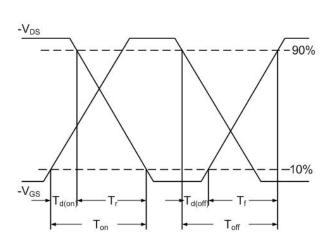


Fig.9 Normalized Maximum Transient Thermal Impedance



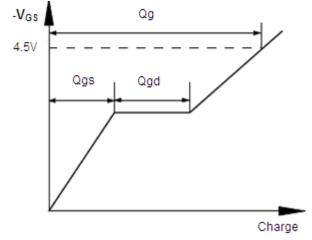
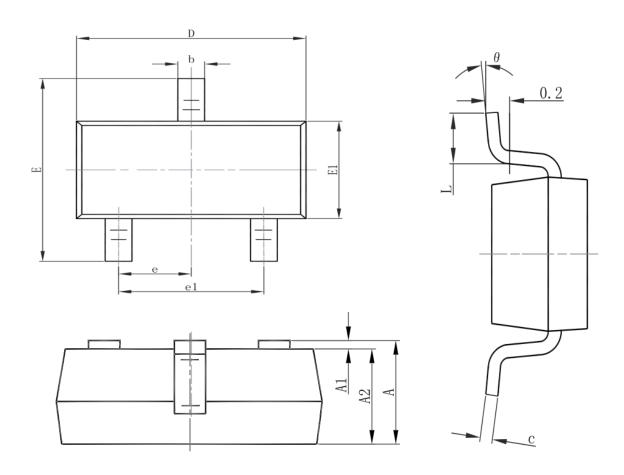


Fig.10 Switching time waveform

Fig.11 Gate Charge waveform



Packaging information



Symbol	Dimensions In Millimeters		Dimensions In Inches		
	Min.	Max.	Min.	Max.	
Α	1.050	1.250	0.041	0.049	
A1	0.000	0.100	0.000	0.004	
A2	1.050	1.150	0.041	0.045	
b	0.300	0.500	0.012	0.020	
С	0.100	0.200	0.004	0.008	
D	2.820	3.020	0.111	0.119	
E1	1.500	1.700	0.059	0.067	
E	2.650	2.950	0.104	0.116	
е	0.950(BSC)		0.037(BSC)		
e1	1.800	2.000	0.071	0.079	
L	0.300	0.600	0.012	0.024	
θ	0°	8°	0°	8°	



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